

Search Notes

Application/Control No.

10/816,272

Examiner

Matthew J. Kohner

Applicant(s)/Patent under
Reexamination

CHANG, DEUK-HWAN

Art Unit

3653

SEARCHED

Class	Subclass	Date	Examiner
271	117, 152,154, 155	8/4/2006	MK

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Discussed Search with Primary Examiner D. Bollingerq	8/3/2006	MK
Forward Backward Search on relevant prior art	8/3/2006	MK
Text search on EAST	8/3/2006	MK